onsemi

MOSFET – N-Channel, Shielded Gate, POWERTRENCH[®]

80 V, 64 A, 6.8 mΩ FDMC007N08LCDC

General Description

This N-Channel MV MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 6.8 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 22 \text{ A}$
- Max $R_{DS(on)} = 11.1 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 18 \text{ A}$
- 5 V Drive Capable
- 50% Lower Q_{rr} than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

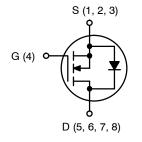
- Primary DC–DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

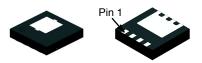
Symbol	Parameter	Value	Unit
V _{DS}	Drain to Source Voltage	80	V
V_{GS}	Gate to Source Voltage	±20	V
I _D	$ Drain Current: \\ Continuous, T_C = 25^\circ C (Note 5) \\ Continuous, T_C = 100^\circ C (Note 5) \\ Continuous, T_A = 25^\circ C (Note 1a) \\ Pulsed (Note 4) $	64 41 15 339	A
E _{AS}	Single Pulse Avalanche Energy (Note 3)	150	mJ
P _D	Power Dissipation: $T_C = 25^{\circ}C$ $T_A = 25^{\circ}C$ (Note 1a)	57 3	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

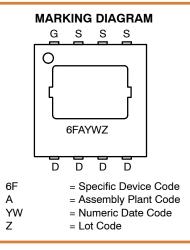
V _{DS}	R _{DS(ON)} MAX	I _D MAX
80 V	6.8 mΩ @ 10 V	22 A
	11.1 m Ω @ 4.5 V	



N-CHANNEL MOSFET



Top Bottom DUAL COOL[®] 33 (PQFN8) CASE 483AY



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ ext{ heta}JC}$	IC Thermal Resistance, Junction to Case		°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1a)	42	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS	•				
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	80			V
$\Delta {\rm BV}_{\rm DSS}$ / $\Delta {\rm T}_{\rm J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, referenced to $25^{\circ}C$		67		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
ON CHARA	CTERISTICS	•	•		•	
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 130 \ \mu A$	1.0	1.5	2.5	V
${\Delta V_{GS(th)} \over /\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 130 \ \mu$ A, referenced to 25°C		-5.2		mV/°0
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 22 \text{ A}$		5.1	6.8	mΩ
		V_{GS} = 4.5 V, I _D = 18 A		7.3	11.1	1
		V_{GS} = 10 V, I_D = 22 A, T_J = 125°C		9.5	12.5	1
9FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 22 \text{ A}$		80		S
OYNAMIC C	CHARACTERISTICS	•	•		•	
C _{iss}	Input Capacitance	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		2195	3070	pF
C _{oss}	Output Capacitance	7		521	730	pF
C _{rss}	Reverse Transfer Capacitance	7		25	40	pF
Rg	Gate Resistance		0.1	0.5	0.9	Ω
WITCHING	CHARACTERISTICS	•	•		•	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, \text{ I}_{D} = 22 \text{ A}, \text{ V}_{GS} = 10 \text{ V},$		11	21	ns
tr	Rise Time	$R_{GEN} = 6 \Omega$		3	10	ns
t _{d(off)}	Turn-Off Delay Time			36	58	ns
t _f	Fall Time			4	10	ns
Qg	Total Gate Charge	V_{GS} = 0 V to 10 V, V_{DD} = 40 V, I _D = 22 A		31	44	nC
		V_{GS} = 0 V to 4.5 V, V_{DD} = 40 V, I_{D} = 22 A		15	21	nC
Q _{gs}	Gate to Source Charge	V _{DD} = 40 V, I _D = 22 A		5		nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{DD} = 40 V, I _D = 22 A		4		nC
Q _{oss}	Output Charge	V _{DD} = 40 V, V _{GS} = 0 V		29		nC
Q _{sync}	Total Gate Charge Sync	V _{DS} = 0 V, I _D = 22 A		28		nC
	IRCE DIODE CHARACTERISTICS	-	-	-	•	•
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.5 A (Note 2)		0.7	1.2	V
		$V_{CS} = 0$ V. $I_{C} = 22$ A (Note 2)		0.8	1.3	1

V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.5 A (Note 2)	0.7	1.2	V
		V_{GS} = 0 V, I _S = 22 A (Note 2)	0.8	1.3	
t _{rr}	Reverse Recovery Time	I_F = 11 A, di/dt = 300 A/µs	18	32	ns
Q _{rr}	Reverse Recovery Charge		24	38	nC

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
t _{rr}	Reverse Recovery Time	$I_F = 11 \text{ A}, \text{ di/dt} = 1000 \text{ A/}\mu\text{s}$		15	26	ns
Q _{rr}	Reverse Recovery Charge			60	96	nC

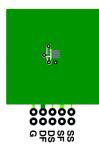
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Top Source)	6.0	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Bottom Source)	2.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	42	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	105	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1c)	29	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1d)	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1e)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1f)	23	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1g)	30	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1h)	79	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1i)	17	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1j)	26	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1k)	12	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1I)	16	°C/W

NOTES:

1. R_{0JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0JC} is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 42°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 105°C/W when mounted on a minimum pad of 2 oz copper.

- c. Still air, 20.9 × 10.4 × 12.7 mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- d. Still air, 20.9 × 10.4 × 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f. Still air, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10–L41B–11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in2 pad of 2 oz copper
- h. 200FPM Airflow. No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9 × 10.4 × 12.7 mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- j. 200FPM Airflow, 20.9 × 10.4 × 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- I. 200FPM Airflow, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. E_{AS} of 150 mJ is based on starting $T_J = 25^{\circ}$ C; L = 3 mH, $I_{AS} = 10$ A, $V_{DD} = 80$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 32$ A. 4. Pulsed ld please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ UNLESS OTHERWISE NOTED})$

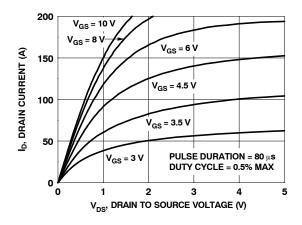
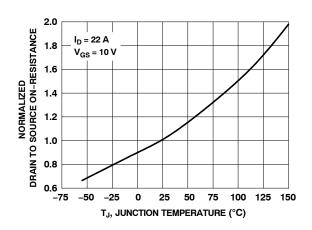


Figure 1. On Region Characteristics





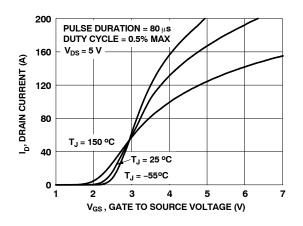


Figure 5. Transfer Characteristics

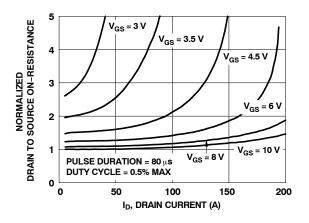
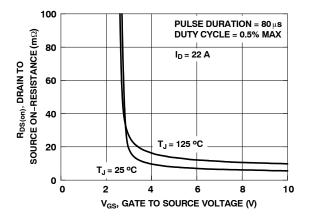
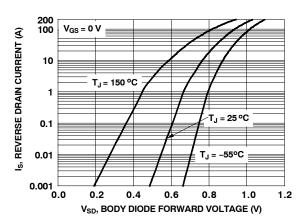


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage









TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ UNLESS OTHERWISE NOTED})$

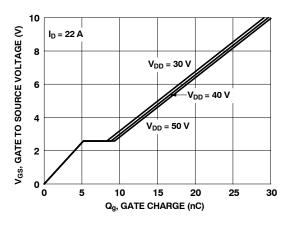
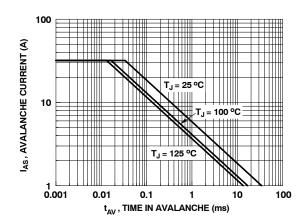


Figure 7. Gate Charge Characteristics





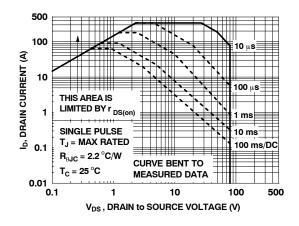


Figure 11. Forward Bias Safe Operating Area

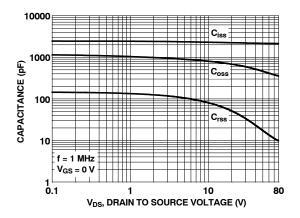


Figure 8. Capacitance vs. Drain to Source Voltage

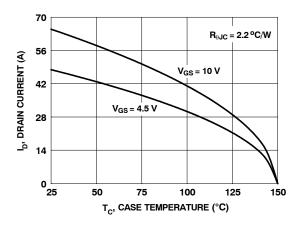


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

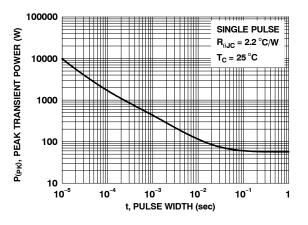


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ UNLESS OTHERWISE NOTED})$

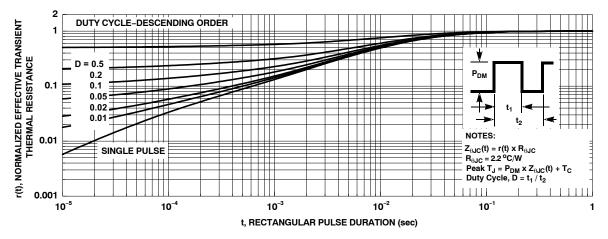


Figure 13. Junction-to-Case Transient Thermal Response Curve

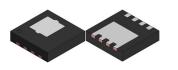
ORDERING INFORMATION

Device	Marking	Package	Reel Size	Tape Width	Quantity
FDMC007N08LCDC	7N08LDC	DUAL COOL 33 (PQFN8) (Pb-Free / Halogen Free)	13″	12 mm	3000 Units

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MECHANICAL CASE OUTLINE

PACKAGE DIMENSIONS



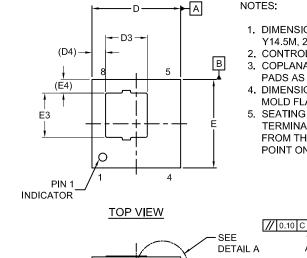
PQFN8 3.3X3.3, 0.65P CASE 483AY **ISSUE A**

DATE 08 SEP 2021

MILLIMETERS

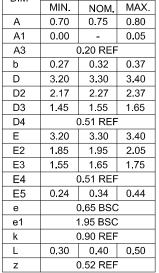
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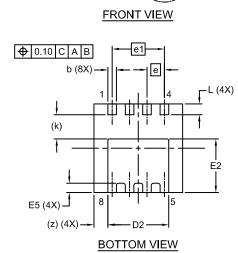
DURSEM



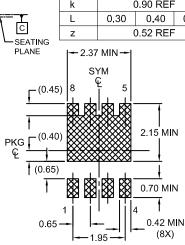
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS 3. COPLANARITY APPLIES TO THE EXPOSED
- PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.





0.08 C Α1 Ċ (A3)



LAND PATTERN RECOMMENDATION

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